

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination WANG ET AL.	
		Examiner Mark Kopec	Art Unit 1751	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	1208020	02-1999	CN	(Abstract)	
	O	09167703	06-1997	JP	(Abstract)	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
	U	"Study of low-temperature sintering Z-type hexaferrites", Zhang, H. G.; Zhou, J.; Yue, Z. X.; Gui, Z. L.; Li, L.T. Proceedings of the China International Conference on High-Performance Ceramics, 1st, Beijing, China, Oct.31-Nov. 3, 1998 (1999).
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.